Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/737,196	RUFF, MATTHIAS	
Examiner	Art Unit	
Khanh V. Nguyen	2817	

	SEAR	EARCHED	
Class	Subclass	Date	Examiner
-			

INT	ERFERENC	E SEARCH	ED
Class	Subclass	Date	Examiner
AP			
	<u> </u>		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
330/10,84,85,148,124R,295; 381/120,121 + Keywords	9/21/2006	NKV		
··· ·	· · · · · ·			
· · · · · · · · · · · · · · · · · · ·				